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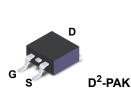
## **FQB5N90 N-Channel QFET® MOSFET** 900 V, 5.4 A, 2.3 Ω

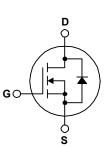
#### Description

This N-Channel enhancement mode power MOSFET is • Low Gate Charge (Typ. 31 nC) produced using ON Semiconductor's proprietary planar - Low Crss (Typ. 13 pF) stripe and DMOS technology. This advanced MOSFET • Low CISS (Typ. 13 pF) technology has been especially tailored to reduce on-state • 100% Avalanche Tested resistance, and to provide superior switching performance • RoHS Compliant and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

#### **Features**

- 5.4 A, 900 V,  $R_{DS(on)}$  = 2.3  $\Omega$  (Max.) @ V<sub>GS</sub> = 10 V, I<sub>D</sub> = 2.7 A





#### Absolute Maximum Ratings T<sub>c</sub> = 25°C unless otherwise noted.

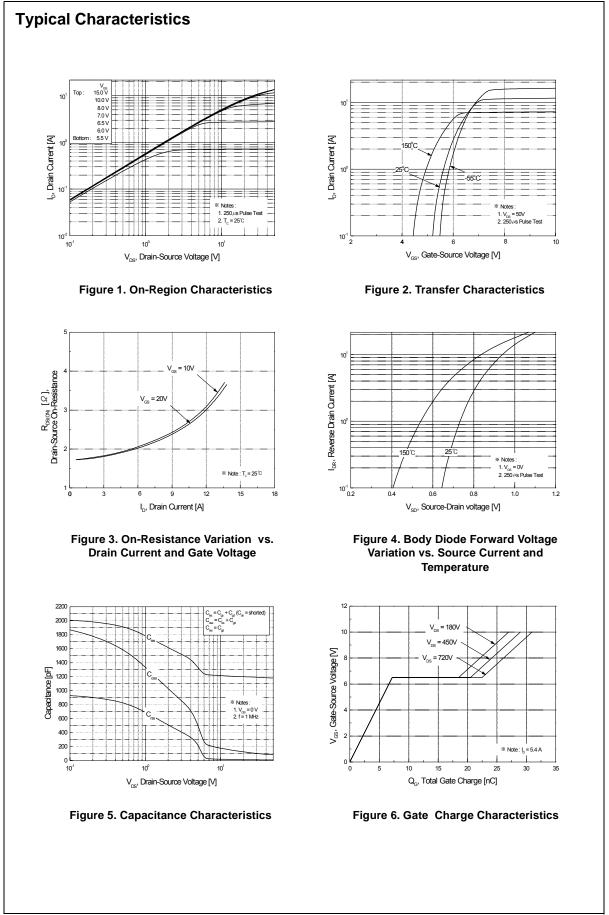
Symbol	Parameter		FQB5N90TM	Unit
V <sub>DSS</sub>	Drain-Source Voltage		900	V
I <sub>D</sub>	Drain Current - Continuous ( $T_C = 25^{\circ}C$ )		5.4	А
	- Continuous (T <sub>C</sub> = 100°C)		3.42	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	21.6	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	660	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	5.4	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	15.8	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.0	V/ns
PD	Power Dissipation $(T_A = 25^{\circ}C)^{*}$		3.13	W
	Power Dissipation ( $T_C = 25^{\circ}C$ )		158	W
	- Derate above 25°C		1.27	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering, 1/8" from case for 5 seconds		300	°C

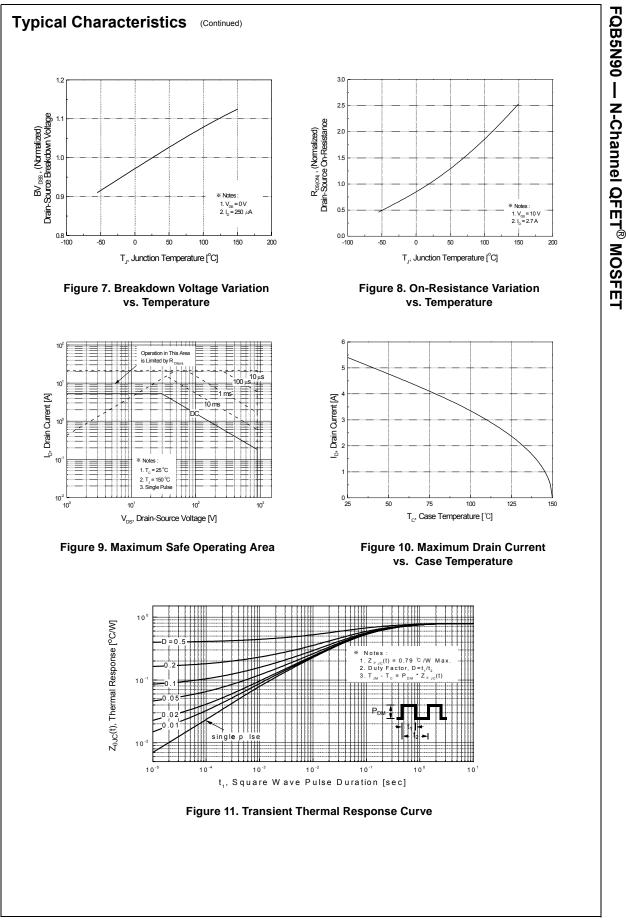
## **Thermal Characteristics**

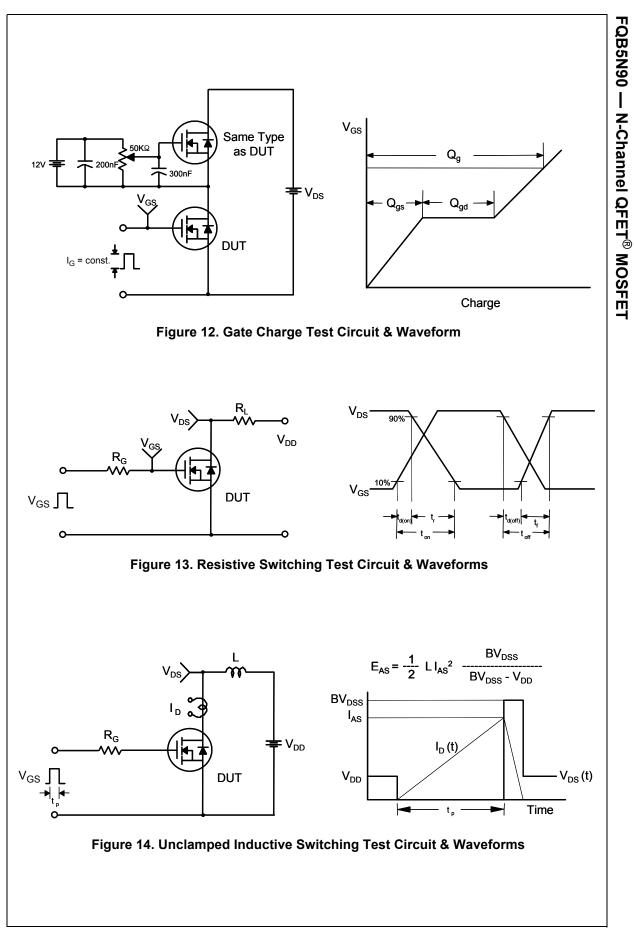
Symbol	Parameter	FQB5N90TM	Unit
$R_{\thetaJC}$	Thermal Resistance, Junction to Case, Max.	0.79	
<b>D</b>	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (*1 in <sup>2</sup> Pad of 2-oz Copper), Max.	40	

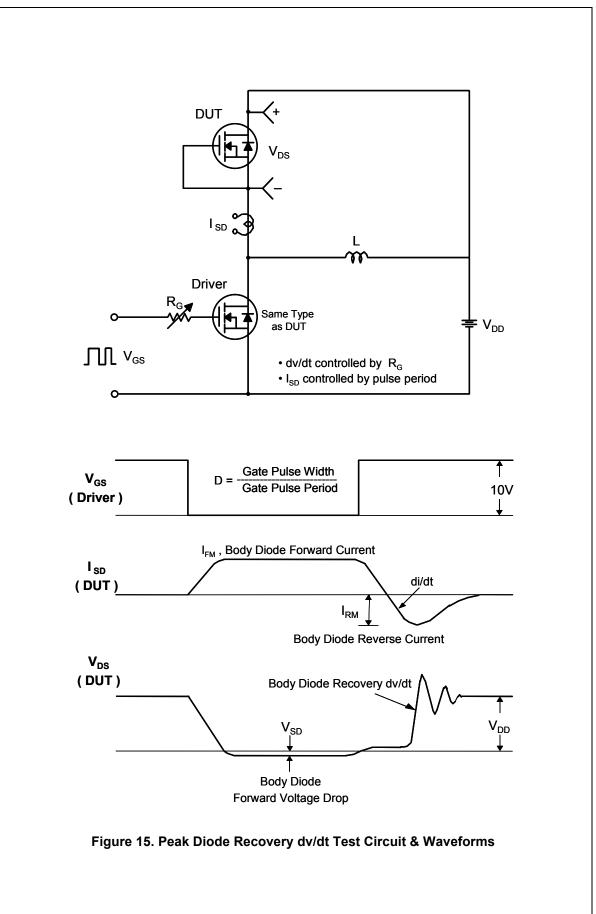
	$I_{D} = 24$ $V_{DS} =$ $V_{DS} =$ $V_{GS} =$ $V_{GS} =$ $V_{DS} =$ $V_{GS} =$ $V_{DS} =$ $V_{DS} =$	Test Conditions $0 V, I_D = 250 \mu A$ $50 \mu A$ , Referenced to $900 V, V_{GS} = 0 V$ $720 V, T_C = 125^{\circ}C$ $30 V, V_{DS} = 0 V$ $-30 V, V_{DS} = 0 V$ $-30 V, V_{DS} = 0 V$ $V_{GS}, I_D = 250 \mu A$ $10 V, I_D = 2.7 A$ $50 V, I_D = 2.7 A$ $25 V, V_{GS} = 0 V,$	0 25°C	Min. 900   3.0  3.0	24 mi Typ.  1.0   1.8 5.6	Max.  10 100 -100 5.0 2.3 	V           V/°C           μA           nA           nA           N           S
Parameter         Pristics         I-Source Breakdown Voltage         kdown Voltage Temperature         ficient         Gate Voltage Drain Current         Body Leakage Current, Forwa         Body Leakage Current, Rever         Pristics         Threshold Voltage         Corain-Source         Resistance         ard Transconductance         Aracteristics         Capacitance         ut Capacitance	$V_{GS} = V_{DS} = V_{DS} = V_{DS} = V_{CS} = V$	Test Conditions $0 V, I_D = 250 \mu A$ $50 \mu A$ , Referenced to $900 V, V_{GS} = 0 V$ $720 V, T_C = 125^{\circ}C$ $30 V, V_{DS} = 0 V$ $-30 V, V_{DS} = 0 V$ $-30 V, V_{DS} = 0 V$ $V_{GS}, I_D = 250 \mu A$ $10 V, I_D = 2.7 A$ $50 V, I_D = 2.7 A$ $25 V, V_{GS} = 0 V,$	> 25°C	900     3.0  	 1.0    1.8	 10 100 -100 -100 5.0 2.3 	V           μA           μA           nA           NA           V
eristics -Source Breakdown Voltage kdown Voltage Temperature ficient Gate Voltage Drain Current -Body Leakage Current, Forwa -Body Leakage Current, Rever eristics Threshold Voltage c Drain-Source desistance ard Transconductance aracteristics Capacitance ut Capacitance	$I_{D} = 2!$ $V_{DS} =$ $V_{DS} =$ $V_{GS} =$ $V_{CS} =$ $V_{DS} =$ $V_{DS} =$ $V_{DS} =$ $V_{DS} =$	$0 \text{ V}, \text{ I}_{\text{D}} = 250 \text{ μA}$ 50  μA,  Referenced to $900 \text{ V}, \text{V}_{\text{GS}} = 0 \text{ V}$ $720 \text{ V}, \text{T}_{\text{C}} = 125^{\circ}\text{C}$ $30 \text{ V}, \text{V}_{\text{DS}} = 0 \text{ V}$ $30 \text{ V}, \text{V}_{\text{DS}} = 0 \text{ V}$ $-30 \text{ V}, \text{V}_{\text{DS}} = 0 \text{ V}$ $\text{V}_{\text{GS}}, \text{ I}_{\text{D}} = 250 \text{ μA}$ $10 \text{ V}, \text{I}_{\text{D}} = 2.7 \text{ A}$ $50 \text{ V}, \text{ I}_{\text{D}} = 2.7 \text{ A}$ $25 \text{ V}, \text{V}_{\text{GS}} = 0 \text{ V},$	) 25°C	900     3.0  	 1.0    1.8	 10 100 -100 -100 5.0 2.3 	V           μA           μA           nA           NA           V
A-Source Breakdown Voltage kdown Voltage Temperature ficient Gate Voltage Drain Current -Body Leakage Current, Forwa -Body Leakage Current, Rever eristics Threshold Voltage c Drain-Source Resistance ard Transconductance aracteristics Capacitance ut Capacitance	$I_{D} = 2!$ $V_{DS} =$ $V_{DS} =$ $V_{GS} =$ $V_{CS} =$ $V_{DS} =$ $V_{DS} =$ $V_{DS} =$ $V_{DS} =$	50 $\mu$ A, Referenced to 900 V, V <sub>GS</sub> = 0 V 720 V, T <sub>C</sub> = 125°C 30 V, V <sub>DS</sub> = 0 V -30 V, V <sub>DS</sub> = 0 V V <sub>GS</sub> , I <sub>D</sub> = 250 $\mu$ A 10 V, I <sub>D</sub> = 2.7 A 50 V, I <sub>D</sub> = 2.7 A 25 V, V <sub>GS</sub> = 0 V,	0 25°C	   3.0 	1.0    1.8	 10 100 -100 5.0 2.3 	V/°C μA μA nA NA V Ω
A-Source Breakdown Voltage kdown Voltage Temperature ficient Gate Voltage Drain Current -Body Leakage Current, Forwa -Body Leakage Current, Rever eristics Threshold Voltage c Drain-Source Resistance ard Transconductance aracteristics Capacitance ut Capacitance	$I_{D} = 2!$ $V_{DS} =$ $V_{DS} =$ $V_{GS} =$ $V_{CS} =$ $V_{DS} =$ $V_{DS} =$ $V_{DS} =$ $V_{DS} =$	50 $\mu$ A, Referenced to 900 V, V <sub>GS</sub> = 0 V 720 V, T <sub>C</sub> = 125°C 30 V, V <sub>DS</sub> = 0 V -30 V, V <sub>DS</sub> = 0 V V <sub>GS</sub> , I <sub>D</sub> = 250 $\mu$ A 10 V, I <sub>D</sub> = 2.7 A 50 V, I <sub>D</sub> = 2.7 A 25 V, V <sub>GS</sub> = 0 V,	9 25°C	   3.0 	1.0    1.8	 10 100 -100 5.0 2.3 	V/°C μA μA nA NA V Ω
ficient Gate Voltage Drain Current Body Leakage Current, Forwa Body Leakage Current, Rever Fristics Threshold Voltage C Drain-Source Lesistance ard Transconductance <b>aracteristics</b> Capacitance ut Capacitance	$V_{DS} = V_{DS} =$ rd $V_{GS} =$ se $V_{GS} =$ $V_{DS} =$ $V_{DS} =$ $V_{DS} =$ $V_{DS} =$	900 V, $V_{GS} = 0 V$ 720 V, $T_C = 125^{\circ}C$ 30 V, $V_{DS} = 0 V$ -30 V, $V_{DS} = 0 V$ $V_{GS}$ , $I_D = 250 \mu A$ 10 V, $I_D = 2.7 A$ 50 V, $I_D = 2.7 A$ 25 V, $V_{GS} = 0 V$ ,	25°C	   3.0  	   1.8	10 100 -100 5.0 2.3 	μΑ μΑ nA nA V
Body Leakage Current, Forwa Body Leakage Current, Rever Pristics Threshold Voltage C Drain-Source Lesistance ard Transconductance aracteristics Capacitance ut Capacitance	V <sub>DS</sub> =           rd         V <sub>GS</sub> =           se         V <sub>GS</sub> =           V <sub>DS</sub> =         V <sub>GS</sub> =           V <sub>DS</sub> =         V <sub>DS</sub> =           V <sub>DS</sub> =         V <sub>DS</sub> =	720 V, $T_C = 125^{\circ}C$ 30 V, $V_{DS} = 0$ V -30 V, $V_{DS} = 0$ V $V_{GS}$ , $I_D = 250 \mu A$ 10 V, $I_D = 2.7 A$ 50 V, $I_D = 2.7 A$ 25 V, $V_{GS} = 0$ V,		  3.0 	   1.8	100 100 -100 5.0 2.3 	μA nA nA V Ω
Body Leakage Current, Forwa Body Leakage Current, Rever Pristics Threshold Voltage C Drain-Source Lesistance ard Transconductance aracteristics Capacitance ut Capacitance	rd V <sub>GS</sub> = se V <sub>GS</sub> = V <sub>DS</sub> = V <sub>GS</sub> = V <sub>DS</sub> =	$\begin{array}{l} 30 \text{ V}, \text{ V}_{\text{DS}} = 0 \text{ V} \\ \hline -30 \text{ V}, \text{ V}_{\text{DS}} = 0 \text{ V} \\ \hline \text{V}_{\text{GS}}, \text{ I}_{\text{D}} = 250 \mu\text{A} \\ \hline 10 \text{ V}, \text{ I}_{\text{D}} = 2.7 \text{ A} \\ \hline 50 \text{ V}, \text{ I}_{\text{D}} = 2.7 \text{ A} \\ \hline 25 \text{ V}, \text{ V}_{\text{GS}} = 0 \text{ V}, \end{array}$		  3.0  	  1.8	100 -100 5.0 2.3 	nA nA V Ω
Body Leakage Current, Rever Pristics Threshold Voltage Drain-Source Resistance ard Transconductance aracteristics Capacitance ut Capacitance	se V <sub>GS</sub> = V <sub>DS</sub> = V <sub>GS</sub> = V <sub>DS</sub> =	$V_{GS}, I_D = 250 \mu A$ $10 V, I_D = 2.7 A$ $50 V, I_D = 2.7 A$ $25 V, V_{GS} = 0 V,$		3.0	  1.8	-100 5.0 2.3 	nA V Ω
ristics Threshold Voltage C Drain-Source tesistance ard Transconductance aracteristics Capacitance ut Capacitance	V <sub>DS</sub> = V <sub>GS</sub> = V <sub>DS</sub> =	$V_{GS}$ , $I_D = 250 \mu A$ 10 V, $I_D = 2.7 A$ 50 V, $I_D = 2.7 A$ 25 V, $V_{GS} = 0 V$ ,		3.0	 1.8	5.0 2.3 	V Ω
Threshold Voltage C Drain-Source Resistance ard Transconductance aracteristics Capacitance ut Capacitance	V <sub>GS</sub> = V <sub>DS</sub> =	10 V, I <sub>D</sub> = 2.7 A 50 V, I <sub>D</sub> = 2.7 A 25 V, V <sub>GS</sub> = 0 V,			1.8	2.3	Ω
c Drain-Source Resistance ard Transconductance aracteristics Capacitance ut Capacitance	V <sub>GS</sub> = V <sub>DS</sub> =	10 V, I <sub>D</sub> = 2.7 A 50 V, I <sub>D</sub> = 2.7 A 25 V, V <sub>GS</sub> = 0 V,			1.8	2.3	Ω
ard Transconductance aracteristics Capacitance ut Capacitance	V <sub>DS</sub> =	50 V, I <sub>D</sub> = 2.7 A 25 V, V <sub>GS</sub> = 0 V,					
aracteristics Capacitance ut Capacitance	V <sub>DS</sub> =	25 V, V <sub>GS</sub> = 0 V,			5.6		S
Capacitance ut Capacitance							<u> </u>
ut Capacitance							
	f = 1.0	N N A I I	$V_{DS} = 25 V, V_{GS} = 0 V,$		1200	1550	pF
rse Transfer Capacitance	1				110	145	pF
· · · ·					13	17	pF
haracteristics							1
On Delay Time	V <sub>DD</sub> =	450 V, I <sub>D</sub> = 5.4 A,			28	65	ns
	R <sub>G</sub> = 2	25 Ω			65		ns
,			(Note 4)				ns
			(11010 4)				ns
-	-					40	nC
•	V <sub>GS</sub> =	10 V					nC
-Drain Charge			(Note 4)		15		nC
e Diode Characteristics	and Max	ximum Ratings					
		•				5.4	A
mum Pulsed Drain-Source Dio	de Forward	Current				21.6	Α
-Source Diode Forward Voltag	e V <sub>GS</sub> =	0 V, I <sub>S</sub> = 5.4 A				1.4	V
rse Recovery Time					610		ns
rse Recovery Charge	dl <sub>F</sub> / d	t = 100 A/μs			5.26		μC
	On Rise Time Off Delay Time Off Fall Time Gate Charge -Source Charge -Drain Charge <b>e Diode Characteristics</b> mum Continuous Drain-Source mum Pulsed Drain-Source Diod	On Rise Time $V_{DD}$ =         Off Delay Time $R_G$ =         Off Fall Time $V_{DS}$ =         Gate Charge $V_{GS}$ =         -Drain Charge $V_{GS}$ = <b>e Diode Characteristics and Ma</b> mum Continuous Drain-Source Diode Forward         n-Source Diode Forward Voltage $V_{GS}$ =         erse Recovery Time $V_{GS}$ =	On Rise Time $V_{DD} = 450 \text{ V}, \text{ I}_D = 5.4 \text{ A}, \text{ R}_G = 25 \Omega$ Off Delay Time $Off$ Fall Time         Off Fall Time $V_{DS} = 720 \text{ V}, \text{ I}_D = 5.4 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$ Source Charge $V_{GS} = 720 \text{ V}, \text{ I}_D = 5.4 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$ -Drain Charge $V_{GS} = 10 \text{ V}$ <b>e Diode Characteristics and Maximum Ratings</b> mum Continuous Drain-Source Diode Forward Current         mum Pulsed Drain-Source Diode Forward Current         h-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 5.4 \text{ A}, \text{ V}_{S} = 0 \text{ V}, \text{ I}_$	On Rise Time $V_{DD} = 450 \text{ V}, I_D = 5.4 \text{ A},$ Off Delay Time $R_G = 25 \Omega$ Off Fall Time $V_{DS} = 720 \text{ V}, I_D = 5.4 \text{ A},$ Gate Charge $V_{DS} = 720 \text{ V}, I_D = 5.4 \text{ A},$ -Source Charge $V_{DS} = 720 \text{ V}, I_D = 5.4 \text{ A},$ -Drain Charge $V_{GS} = 10 \text{ V}$ <b>e Diode Characteristics and Maximum Ratings</b> mum Continuous Drain-Source Diode Forward Current         mum Pulsed Drain-Source Diode Forward Current         n-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_S = 5.4 \text{ A},$ rese Recovery Time $V_{GS} = 0 \text{ V}, I_S = 5.4 \text{ A},$ erse Recovery Charge $V_{IF} / dt = 100 \text{ A}/\mu \text{s}$	On Rise Time $V_{DD} = 450 \text{ V}, \text{ I}_D = 5.4 \text{ A},$ Off Delay Time $R_G = 25 \Omega$ Off Fall Time $(\text{Note 4})$ Gate Charge $V_{DS} = 720 \text{ V}, \text{ I}_D = 5.4 \text{ A},$ Source Charge $V_{GS} = 10 \text{ V}$ Drain Charge $(\text{Note 4})$ <b>e Diode Characteristics and Maximum Ratings</b> mum Continuous Drain-Source Diode Forward Currentmum Pulsed Drain-Source Diode Forward Currentn-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 5.4 \text{ A},$ erse Recovery Time $V_{GS} = 0 \text{ V}, \text{ I}_S = 5.4 \text{ A},$ erse Recovery Charge $dI_F / dt = 100 \text{ A/µs}$	On Rise Time $V_{DD} = 450 \text{ V}, \text{ I}_D = 5.4 \text{ A}, \text{ R}_G = 25 \Omega$ 65-Off Delay Time(Note 4)50Off Fall Time(Note 4)50Gate Charge $V_{DS} = 720 \text{ V}, \text{ I}_D = 5.4 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$ 31-Source Charge $V_{DS} = 720 \text{ V}, \text{ I}_D = 5.4 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$ 7.2-Drain Charge(Note 4)15e Diode Characteristics and Maximum Ratingsmum Continuous Drain-Source Diode Forward Currentmum Pulsed Drain-Source Diode Forward Currentn-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 5.4 \text{ A}, \text{erse Recovery TimeV_{GS} = 0 \text{ V}, \text{ I}_S = 5.4 \text{ A}, \text{of the secovery ChargedI_F / dt = 100 \text{ A/}\mu\text{s}5.26$	On Rise Time $V_{DD} = 450 \text{ V}, I_D = 5.4 \text{ A},$ 65       140         -Off Delay Time        65       140         -Off Fall Time        65       140         Off Fall Time        50       110         Gate Charge $V_{DS} = 720 \text{ V}, I_D = 5.4 \text{ A},$ 31       40         -Source Charge $V_{GS} = 10 \text{ V}$ 7.2          -Drain Charge        15 <b>e Diode Characteristics and Maximum Ratings</b> mum Continuous Drain-Source Diode Forward Current         5.4         mum Pulsed Drain-Source Diode Forward Current         1.4         rese Recovery Time $V_{GS} = 0 \text{ V}, I_S = 5.4 \text{ A},$ 610          erse Recovery Charge       dI <sub>F</sub> / dt = 100 A/µs        5.26

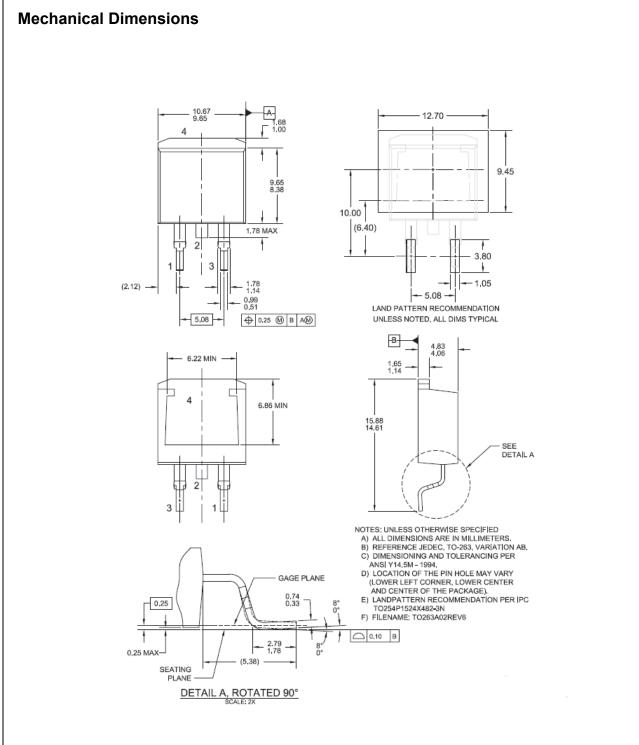
FQB5N90 — N-Channel QFET<sup>®</sup> MOSFET











### Figure 16. TO263 (D<sup>2</sup>PAK), Molded, 2-Lead, Surface Mount

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